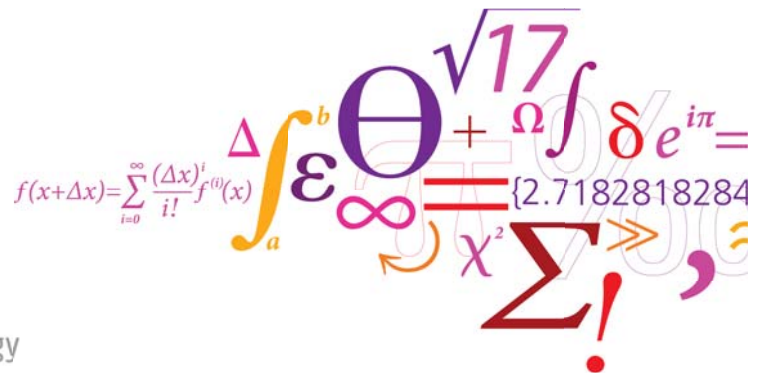


# Degradation Testing - Quantification & Interpretation

*2<sup>nd</sup> International Workshop on Degradation Issues of Fuel Cells  
Thessaloniki, Greece, 21-23 September, 2011*

Johan Hjelm  
Fuel Cells and Solid State Chemistry Division  
Risø National Laboratory for Sustainable Energy  
Technical University of Denmark  
Roskilde, Denmark



Risø DTU  
National Laboratory for Sustainable Energy

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## Outline

- Ways of Viewing Degradation
- Limits of Safe Operation
- Cell Performance Metrics (ASR)
- Degradation Rates determined from Current - Voltage Data
- Lifetime - Degradation Rate - Testing Considerations
- Summary and Conclusion

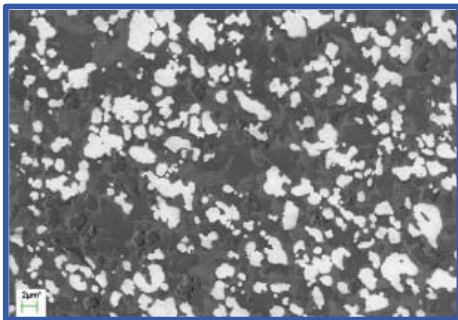
# Types of Degradation in SOFCs (I)

- **Irreversible Degradation**

- Microstructural coarsening
- Decomposition
- Reactions
- Interdiffusion
- Delamination...
- ...

- **Reversible** (Passivation / Re-activation)

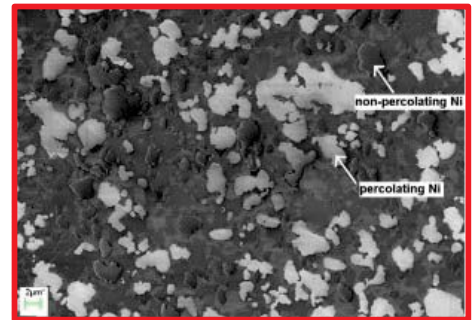
- S poisoning / S oxidative removal (anode)
- Instantaneous effect of H<sub>2</sub>O on LSM cathodes
- exsolution / re-dissolution of metal ions (cathode)
- ...



Ni-coarsening and reduction of connectivity within Ni-phase in anode cermet



from aging experiments at 884 °C in dilute H<sub>2</sub>



M. Pihlatie *et al*; *Solid State Ionics*, 2011, 189, 82

# Types of Degradation in SOFCs

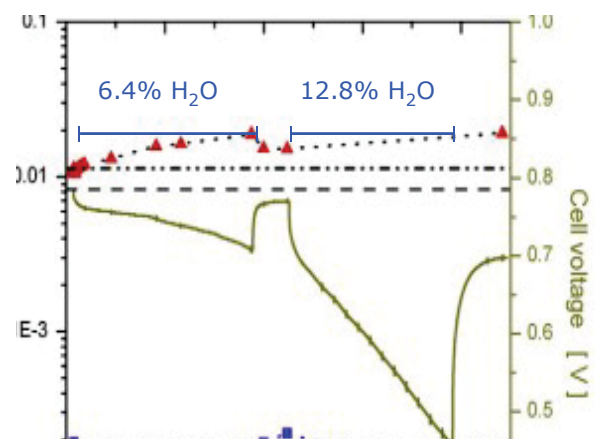
- **Irreversible Degradation**

- Microstructural coarsening
- Decomposition
- Reactions
- Interdiffusion
- Impurity accumulation at TPBs...
- ...

- **Reversible** (Passivation / Re-activation)

- S poisoning / S oxidative removal (anode)
- Instantaneous effect of H<sub>2</sub>O on LSM cathodes
- exsolution / re-dissolution of metal ions (cathode)
- ...

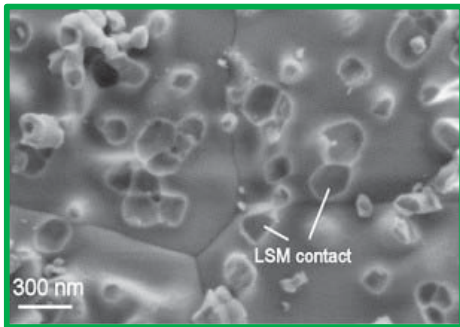
Influence of water vapour on LSM-YSZ cathode from test on anode-supported SOFC under operation at 0.41 A cm<sup>-2</sup> and 750 °C.



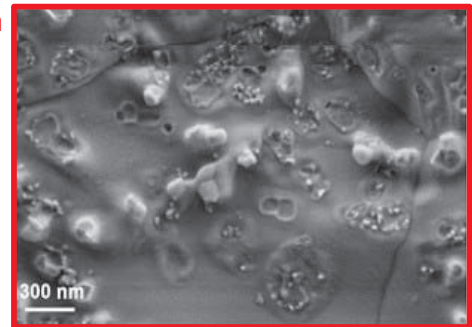
Passivation is observed along with some extent of irreversible degradation.

Nielsen *et al*; *Solid State Ionics*, 2011, 189, 74

# Types of Degradation in SOFCs



Secondary phase formation in anode supported SOFC tested at for 1500 h at 0.75 A cm<sup>-2</sup> and 750 °C leading to reduced TPB.



Reference Cell

Y.-L. Liu *et al*; *Solid State Ionics*, 2009, 180, 1298

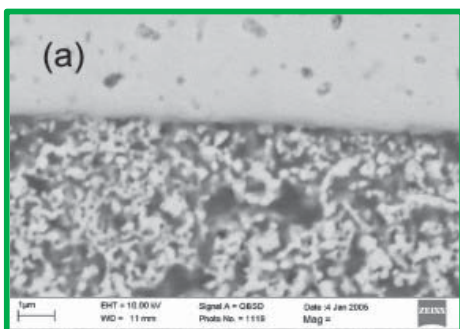
## • Chemical Degradation

- Interdiffusion of components
- Reactions between components (secondary phase formation)
- Poisoning (Cr, S, ...)

## • Physical Degradation

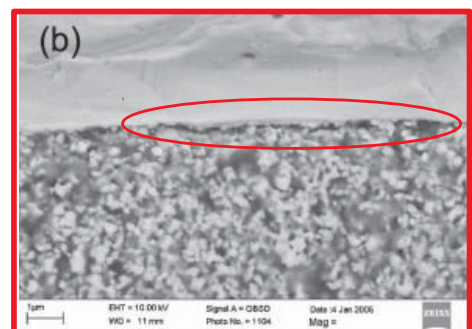
- Microstructural Coarsening
- Cracking (e.g. as a result of redox...)
- Delamination

# Types of Degradation in SOFCs



Cell with LSM-YSZ cathode tested at high current density

Cell with LSM-YSZ cathode tested at low current density



A. Hagen *et al*; *J. Electrochem. Soc.*, 2006, 153, A1165

## • Chemical Degradation

- Interdiffusion of components
- Reactions between components (secondary phase formation)
- Poisoning (Cr, S, ...)

## • Physical Degradation

- Microstructural coarsening
- Cracking (e.g. as a result of re-oxidation of Ni...)
- **Delamination**

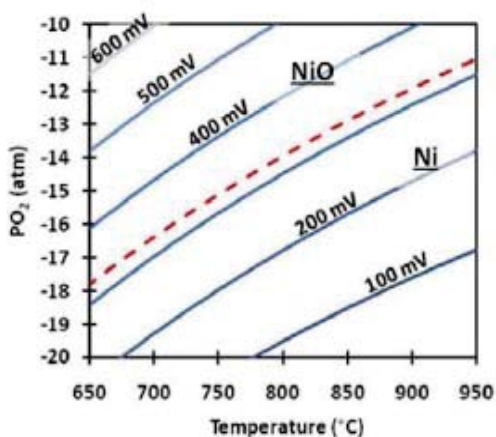
# Types of Degradation in SOFCs

- **Intrinsic** degradation
  - Microstructural coarsening
  - Interdiffusion
  - Impurities in raw materials
  - Decomposition
  - ...
- **Extrinsic** degradation
  - Gas phase impurities (S, Si, Cr...)
  - “Unsafe” operating conditions
    - leading to redoxing
    - leading to carbon deposition
    - leading to secondary phase formation
    - ...

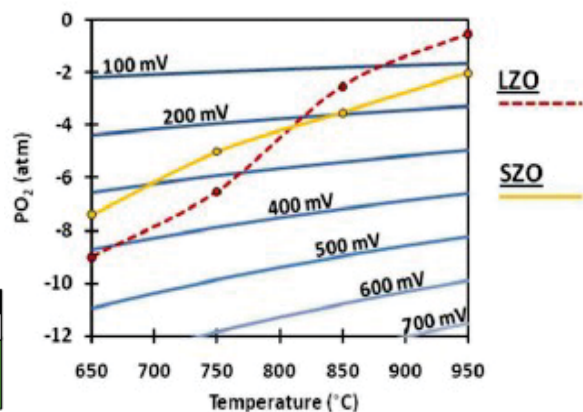
➔ For establishing the maximum lifetime of a cell the rate of **irreversible** & **intrinsic** degradation is a good place to start

→ This represents the “base” degradation rate of the cell and corresponds to the unavoidable part of the degradation of the cell

## Limits of Safe Operation



Max anode overvoltage  
~ 300 mV  
for Ni-based cermet anodes



Max cathode overvoltage  
temperature dependent.  
Ranges from ~ 50 mV to 300 mV  
for LSM25 and 8YSZ.

➔ Measurements of the intrinsic (and irreversible) degradation rate should take place within limits of safe operation to avoid harmfully high overvoltages (high/low  $pO_2$ ) and additional “extrinsic” degradation

Y.-L. Liu *et al*; *Solid State Ionics*, 2009, 180, 1298

R. Knibbe *et al*; *Green*, 2011, 1, 141

# Cell Performance Metrics - ASR

ASR = area specific resistance ( $\Omega \cdot \text{cm}^2$ )

## Secant ASR

$$ASR_{sec} = \frac{emf - U_{cell}}{j_{cell}}$$

## Takes leaks into account

$$ASR_{sec} = \frac{OCV - U_{cell}}{j_{cell}}$$

## Correction for reactant utilization

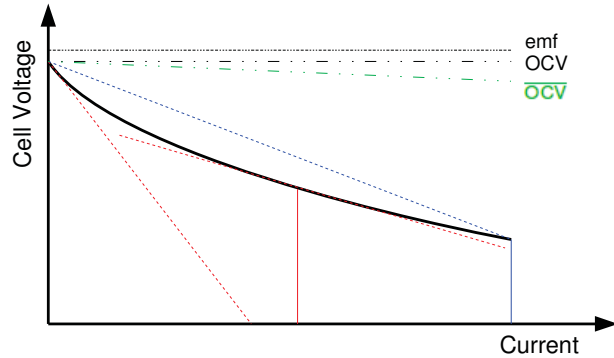
$$ASR_{sec, corr} = \frac{\overline{OCV} - U_{cell}}{j_{cell}}$$

## Tangential ASR

$$ASR_{tan} = \frac{U_1 - U_2}{j_1 - j_2} = \frac{\Delta U_{cell}}{\Delta j_{cell}}$$

## Differential ASR

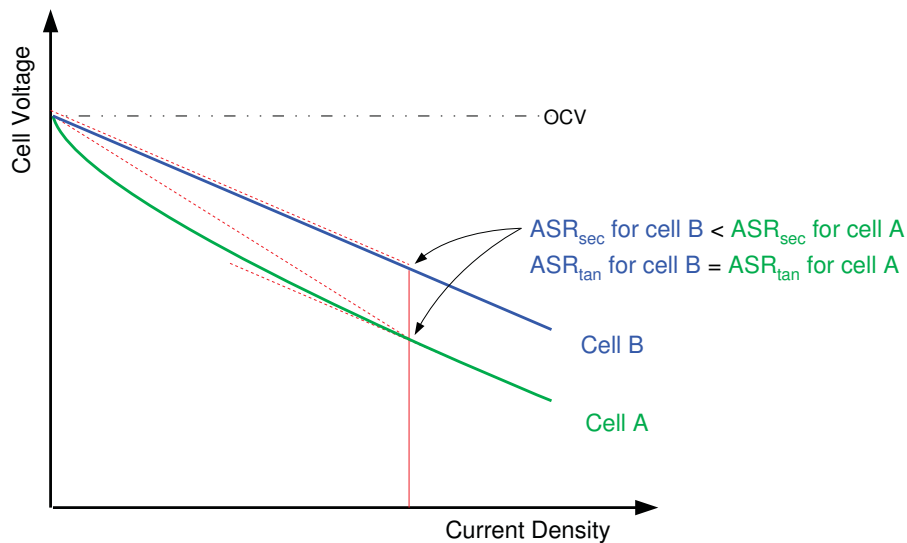
$$ASR_{diff} = \frac{dU}{dj} \quad \text{corresponds to real part of cell impedance...}$$



P.V. Hendriksen and M. Mogensen; in "High temperature SOFC", ed. S.C. Singhal and K. Kendall, Elsevier, 2003

# Cell Performance Metrics - ASR

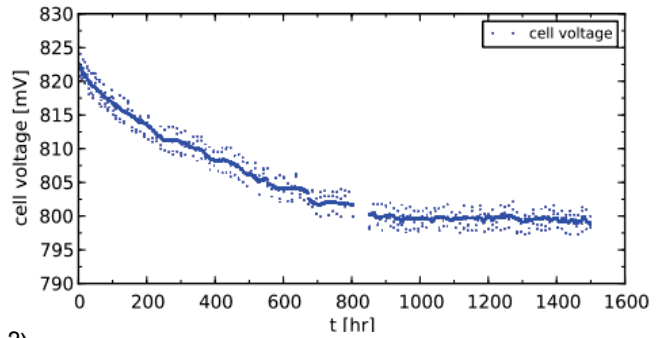
## Tangential vs Secant Resistance



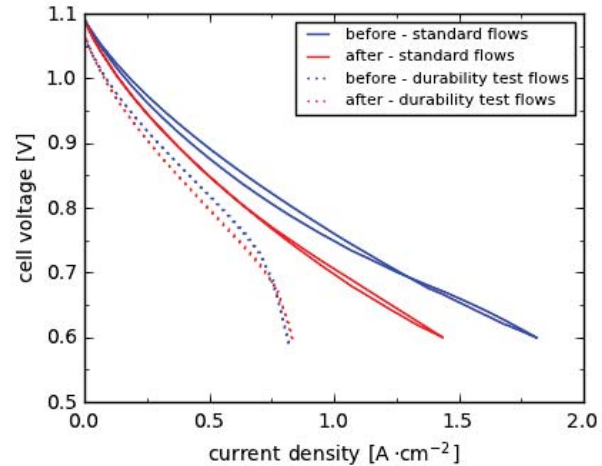
Recommendation: Use secant ASR!  
For correlation with EIS - Use tangential ASR

# Degradation Rate from Polarisation Curves

Test data from a durability test of an anode supported SOFC at constant current ( $0.5 \text{ A cm}^{-2}$ )



Polarisation Curve:  $ASR_{sec,corr}$  (at  $0.5 \text{ A cm}^{-2}$ ):  
*before test (std. flows)*  $0.33 \text{ } \Omega \cdot \text{cm}^2$   
*after test*  $0.38 \text{ } \Omega \cdot \text{cm}^2$   
*before test (dur. flows)*  $0.29 \text{ } \Omega \cdot \text{cm}^2$   
*after test*  $0.34 \text{ } \Omega \cdot \text{cm}^2$



➔  $\Delta ASR_{sec,corr}$  at  $0.5 \text{ A cm}^{-2} = +50 \text{ m}\Omega \cdot \text{cm}^2$  during 1500 h operation  
 ➔  $+33 \text{ m}\Omega \cdot \text{cm}^2 \text{ kh}^{-1}$

➔ This overall degradation rate takes into account initial performance drop

# Degradation Rates from Cell Voltage Data

Defining a degradation rate:

- Usually given as a change of cell voltage or cell resistance with time
- Often given as a normalized change with time (operating point dependent)
- Desirable with an unambiguous measure for degradation (not operating point dependent)

$$U_{cell}(j, t) = OCV(t) - i(t)R_{sec}(t) = OCV(t) - j(t)ASR_{sec}(t)$$

$$OCV(t) = const.$$

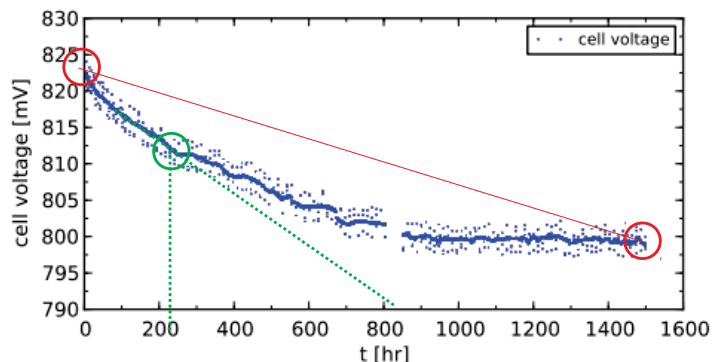
$$j(t) = const.$$

Instantaneous degradation rate:

$$\frac{d(U_{cell}(t))}{dt} = \frac{-d(ASR_{sec}(t))}{dt} j$$

Normalized Instantaneous Degradation Rate:

$$\frac{d(U_{cell}(t))/dt}{U_{cell}(t_0)} = \frac{-d(ASR_{sec}(t))}{dt} j$$

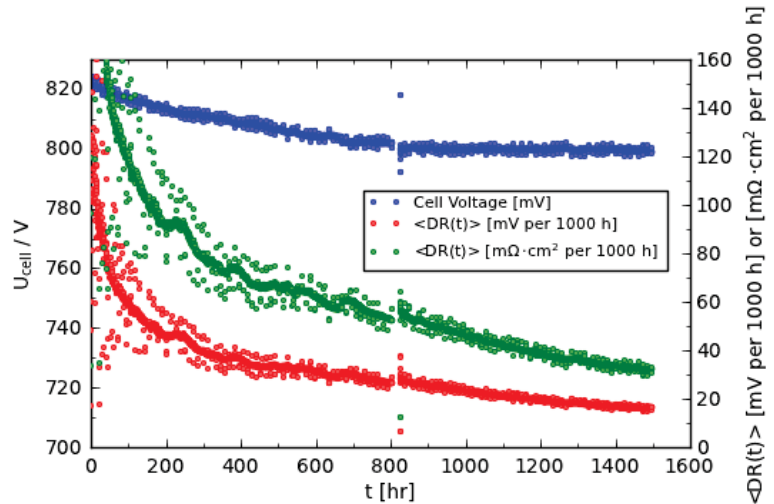


Average / Linearized degradation rate(s)

# Degradation Rates from Cell Voltage Data

Average degradation rate calculated from  $U_{cell}(t_0)$  and  $U_{cell}(t)$

$$\overline{DR}(t) = \frac{U_{cell}(t) - U_{cell}(t_0)}{(t - t_0)}$$



$$\overline{DR}(t) = \frac{U_{cell}(t) - U_{cell}(t_0)}{U_{cell}(t_0)(t - t_0)} \quad \text{mV} \cdot \text{h}^{-1}$$

→ ~31  $\text{m}\Omega \cdot \text{cm}^2 \text{kh}^{-1}$   
(under the assumption that OCV was constant)

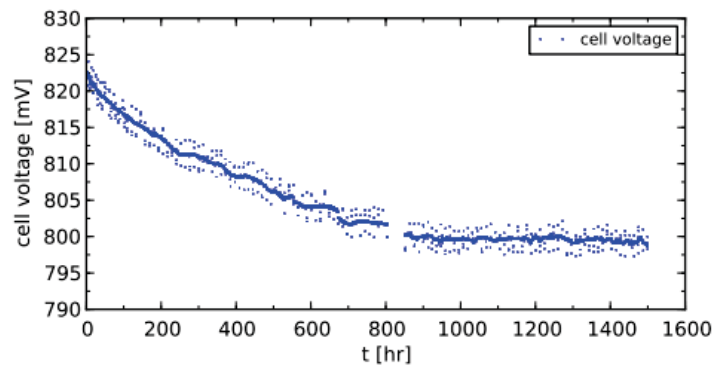
$$\overline{DR}(t) = \frac{U_{cell}(t) - U_{cell}(t_0)}{j_{cell}(t - t_0)} \quad \text{m}\Omega \cdot \text{cm}^2 \text{h}^{-1}$$

→ ~33  $\text{m}\Omega \cdot \text{cm}^2 \text{kh}^{-1}$   
(from polarisation curves,  $\Delta ASR_{sec,corr}$  at  $0.5 \text{ A cm}^{-2}$ )

# Instantaneous Degradation Rate

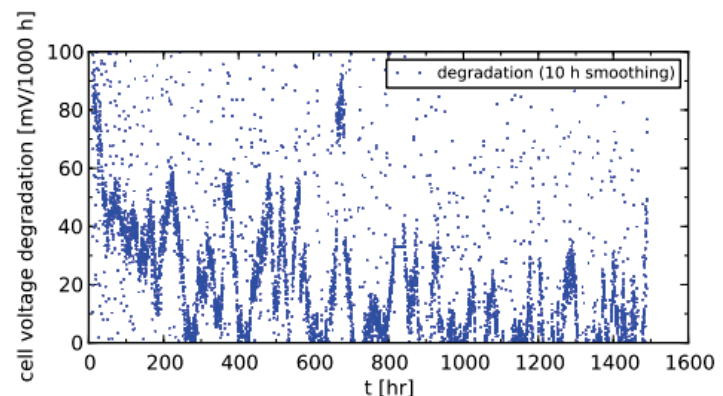
Test data from a durability test of an anode supported SOFC at constant current ( $0.5 \text{ A cm}^{-2}$ )

Data is noisy due to periodic impedance measurements...



$$\frac{d(U_{cell}(t))}{dt} = \frac{-d(ASR_{sec}(t))}{dt} j$$

Instantaneous degradation rates difficult to determine without some form of "filtering" e.g.



- averaging

- linearization

# Local Linear and Averaged Degradation Rates

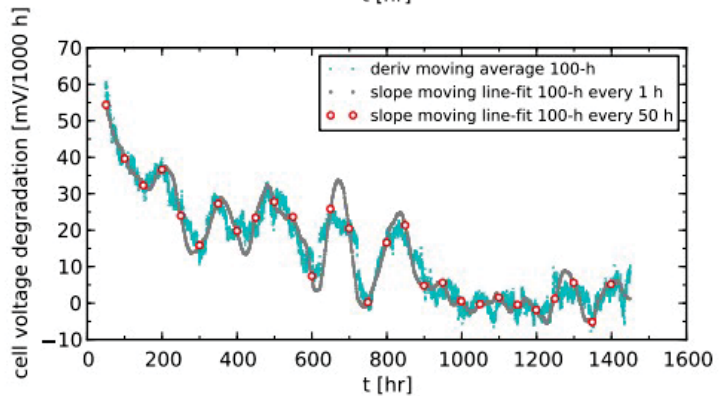
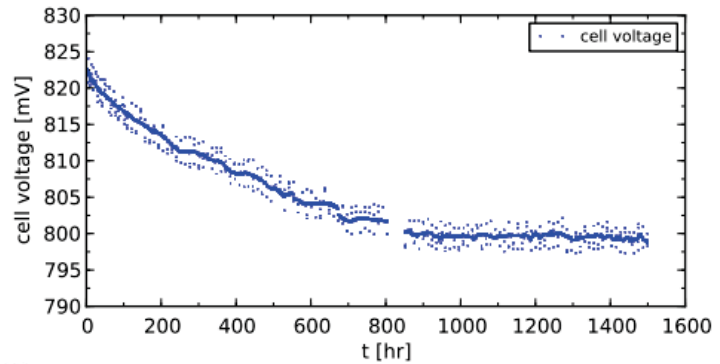
Test data from a durability test of an anode supported SOFC at constant current ( $0.5 \text{ A cm}^{-2}$ )

Data is noisy due to periodic impedance measurement.

Moving Average

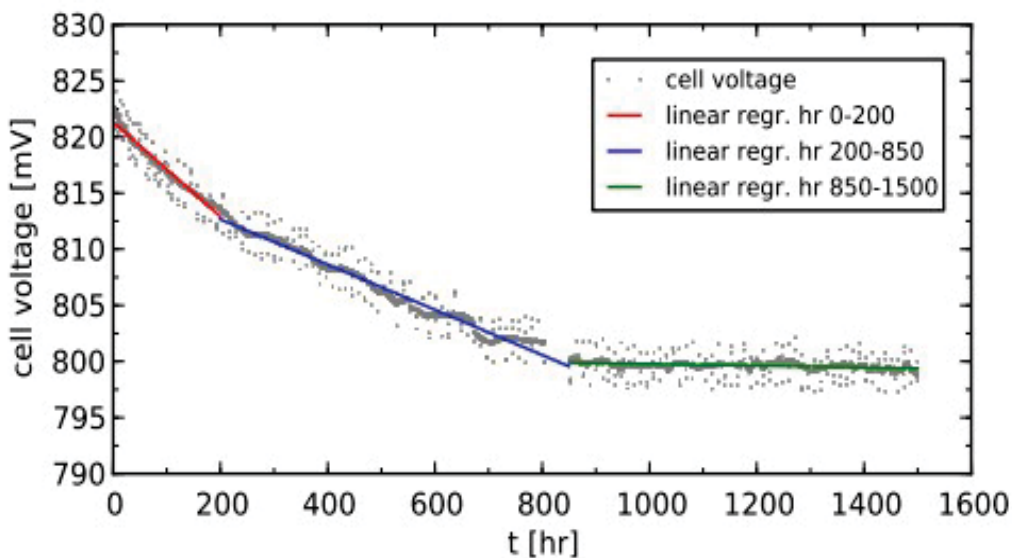
Moving Linear Fits

➔ Degradation rate approaching  $\sim 5 \text{ mV kh}^{-1}$  or  $\sim 10 \text{ m}\Omega\text{-cm}^2 \text{ kh}^{-1}$  but longer test time needed to overcome noise!



Moving Linear Fits, see → I. Vinke, Proc. Workshop on Degradation, Crete, Greece, Sept 20, 2007

# Linearized Degradation Rates



→  $\sim 42 \text{ mV kh}^{-1}$   
 $84 \text{ m}\Omega\text{-cm}^2 \text{ kh}^{-1}$

→  $\sim 20 \text{ mV kh}^{-1}$   
 $40 \text{ m}\Omega\text{-cm}^2 \text{ kh}^{-1}$

→  $\sim 0.8 \text{ mV kh}^{-1}$   
 $1.6 \text{ m}\Omega\text{-cm}^2 \text{ kh}^{-1}$

Initial degradation

“Long-term degradation”  
(although is the measurement time sufficient?)



# Degradation - Lifetime - Test Time

Lifetime: 5 years = 43800 h

For example:

$$OCV = 1.1 \text{ V}$$

$$j_{cell} = 0.5 \text{ A}\cdot\text{cm}^{-2}$$

$$ASR_{cell}(t = 0) = 200 \text{ m}\Omega\cdot\text{cm}^2$$

10% decrease in  $U_{cell}$  over 40000 h

$$U_{cell}(t = 0 \text{ h}) = 1.0 \text{ V}$$

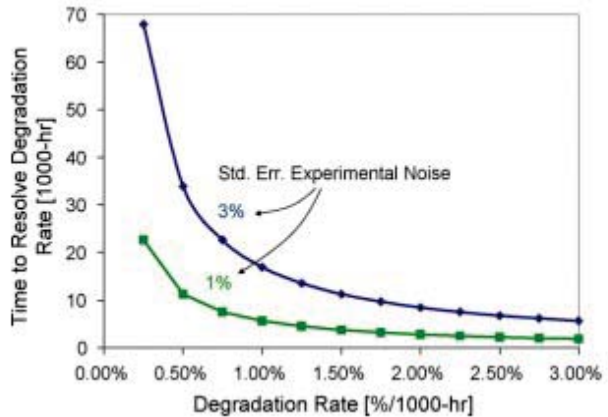
$$U_{cell}(t = 40000 \text{ h}) = 0.9 \text{ V}$$

$$ASR_{cell}(t = 40000 \text{ h}) = 400 \text{ m}\Omega\cdot\text{cm}^2$$



$$DR_U(t) = 2.5 \text{ mV kh}^{-1} \leftrightarrow 0.25\% \text{ per } 1000 \text{ h}$$

$$DR_{ASR}(t) = 5 \text{ m}\Omega\cdot\text{cm}^2 \text{ kh}^{-1}$$



R.S. Gemmen *et al*; *J. Power Sources*, 2008, 184, 251

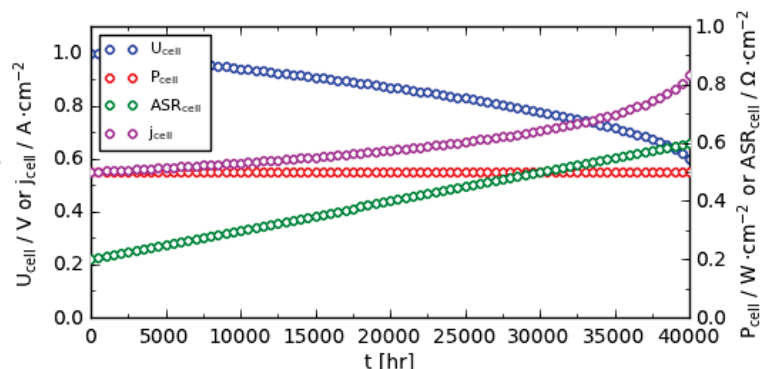
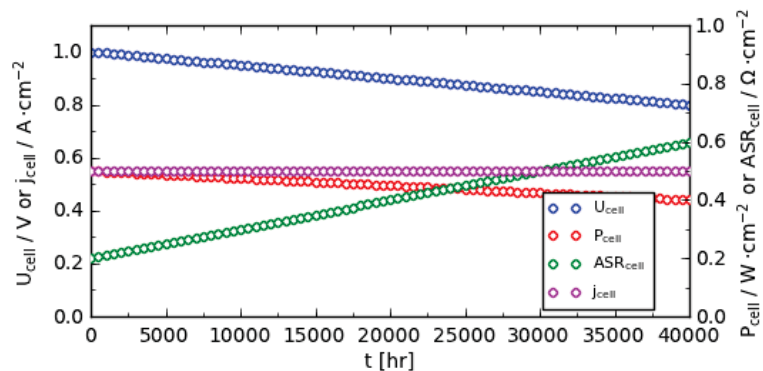


**Decreasing degradation rates demands longer test times (or acceleration...)**

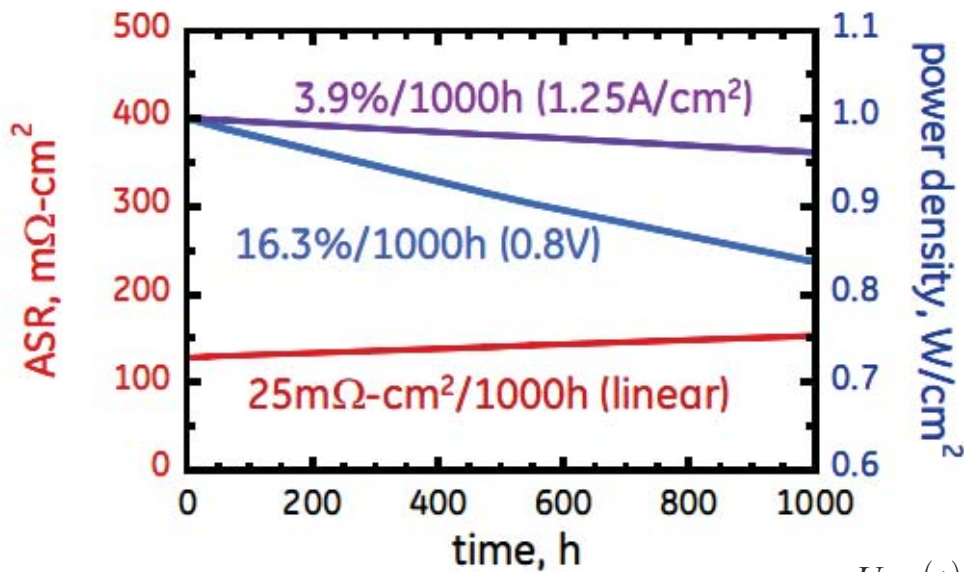
# Stationary Conditions

Many processes are strongly influenced by the thermodynamic state (overpotential,  $pO_2$ ) at the electrodes. Will change with electrode resistance.

Degradation testing at "stationary conditions" carried out at **constant current** (and pressure, temperature) avoids further change in conditions due to that the current density and reactant utilization is kept constant with time - unlike the situation when constant power or constant voltage is used.



# Degradation Metrics - Operating Mode



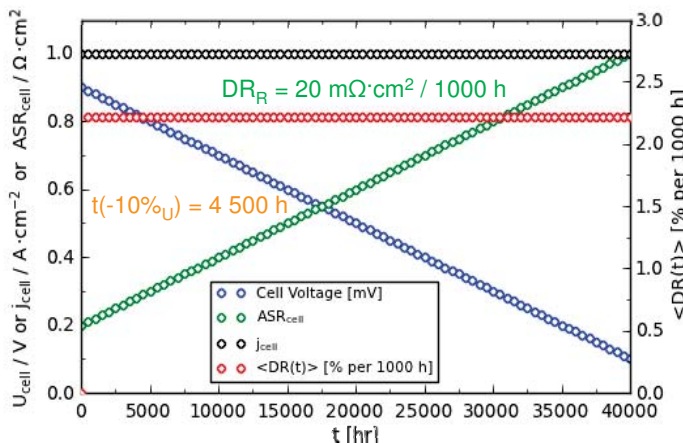
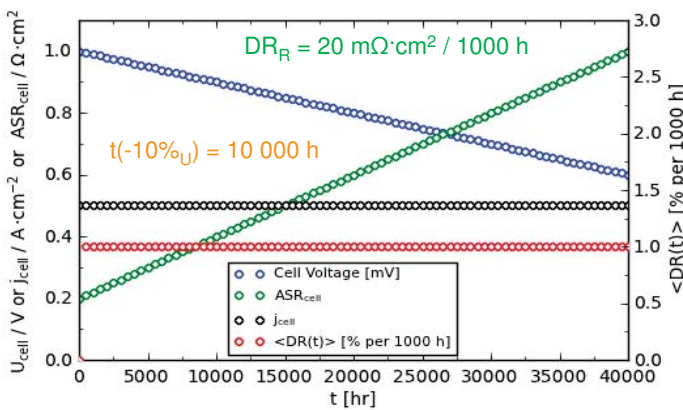
$$P_{U=const} = \frac{U_{cell}(t)(OCV - U_{cell}(t))}{ASR}$$

$$P_{j=const} = OCV - ASR * j_{cell}$$

M. J. Alinger, SECA Final Report, August 2009  
 Degradation Workshop - Greece - 2011 22/09/2011

➔ ASR is the most useful metric for quantification and understanding of degradation...

# Degradation Rates & Lifetime



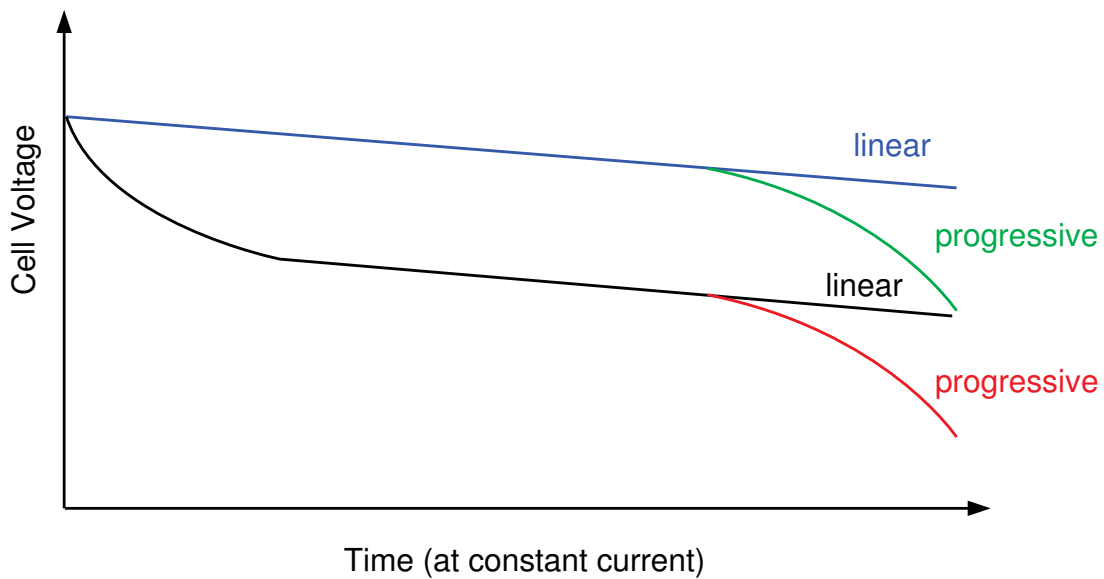
“Lifetime” at a given acceptable loss in cell voltage or power output depends on the current density and the cell resistance

The relative degradation rate is different for the same resistance degradation at different current densities

**Absolute ASR degradation rate the most useful degradation metric.**

OCV = 1.1 V; ASR<sub>cell</sub>(t = 0) = 200 mΩ·cm<sup>2</sup>  
 degradation rate = 20 mΩ·cm<sup>2</sup> / 1000 h

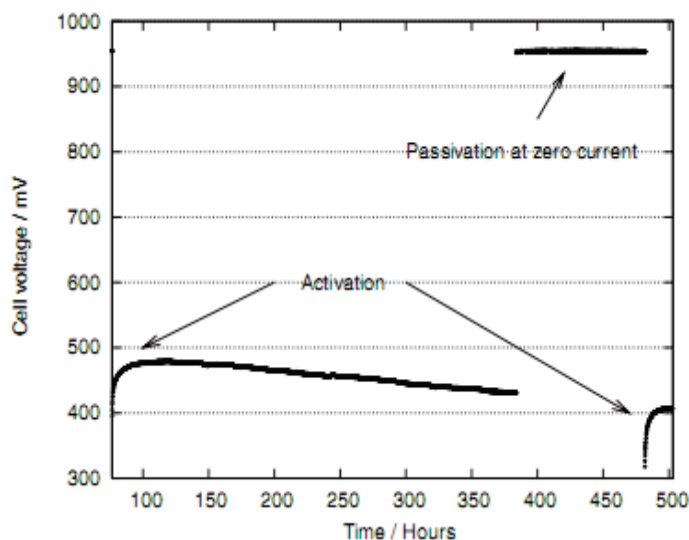
# Trends in Cell Voltage Data



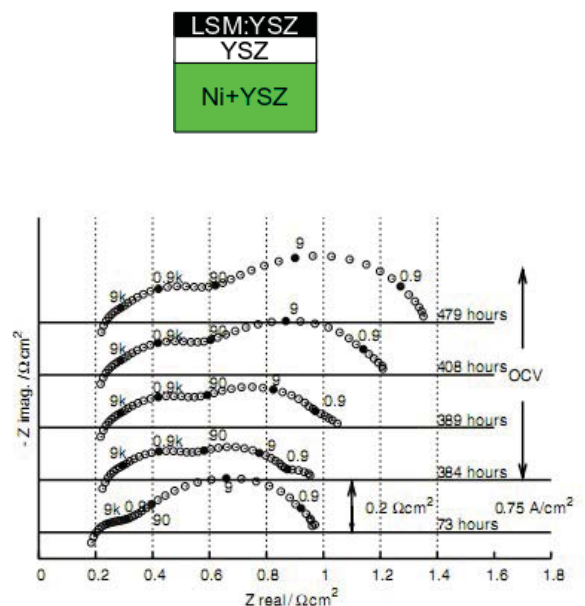
➔ Progressive or accelerating degradation - no steady-state long-term degradation can be determined. Important to identify root causes of degradation.

L.G.J. De Haart *et al*; Fuel Cells, 2009, 09, No 6, 794-804

# Degradation Testing - Pitfalls



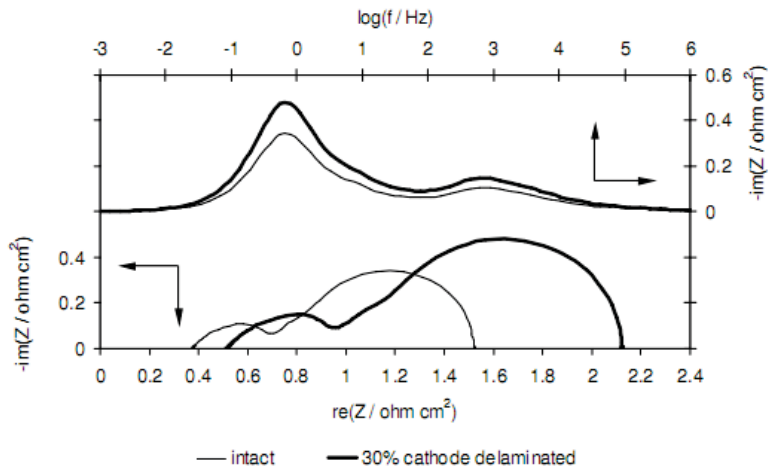
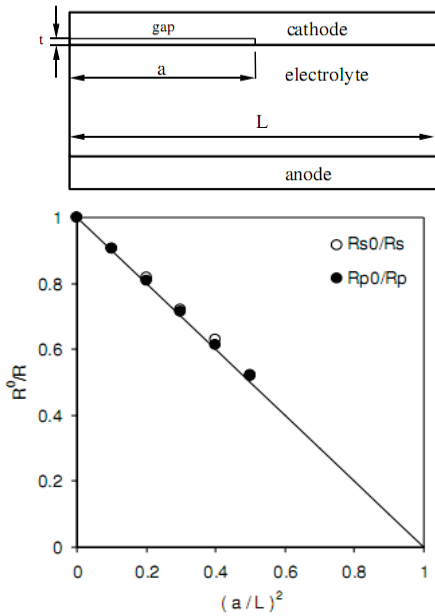
➔ Performance measurements carried out before / after test does not yield a correct value for the degradation when such activation / passivation occurs



S. Koch *et al*, Fuel Cells, 2006, 06, No. 2, 117-122

# Delamination - In Cells and Stacks

delamination = physical (mechanical) degradation  
 delamination or formation of insulating layer at electrode/electrolyte interface,  
 contact loss at interconnect / electrode interface



Electrode delamination - ionic path interrupted

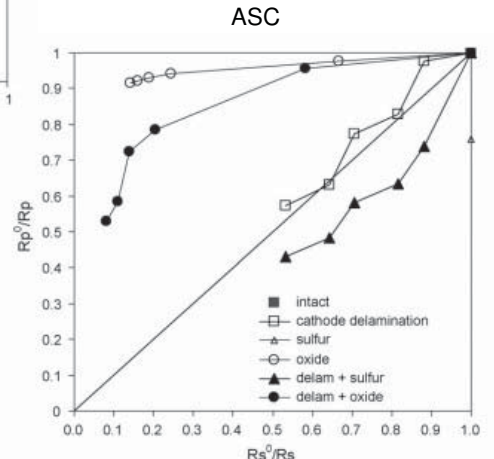
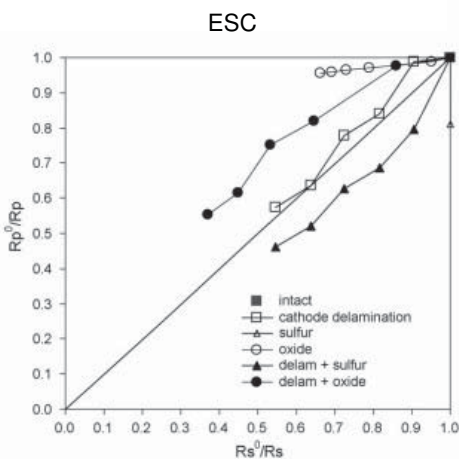
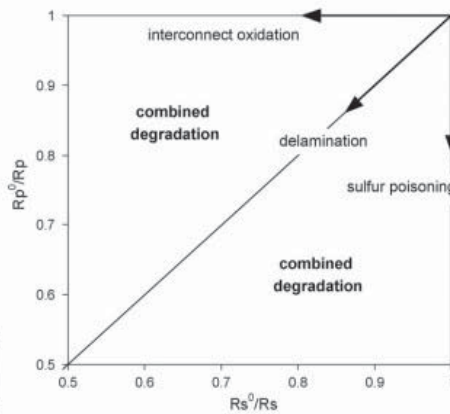


Interconnect detachment from electrode -  
 electronic path interrupted  
 (less severe  $R_0/R$  change)

J.I. Gazzarri *et al*, Journal of Power Sources 2007, 167, 100  
 J.I. Gazzarri *et al*, Journal of Power Sources 2007, 167, 430  
 J.I. Gazzarri, PhD thesis, University of British Columbia, Canada (2007)

# Detection of Multiple Degradation Modes

2D Model for Short Stack SRU  
 - both ESC and ASC

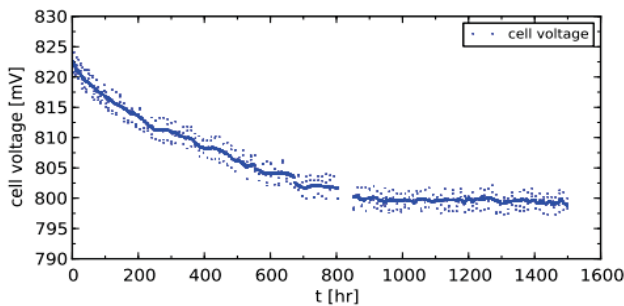


J.I. Gazzarri *et al*, Journal of Power Sources 2008, 176, 138  
 J.I. Gazzarri *et al*, Journal of Power Sources 2007, 176, 155  
 J.I. Gazzarri, PhD thesis, University of British Columbia, Canada (2007)

# Summary

- How can Degradation be Described?**  
 Useful to identify the type of degradation studied
- Degradation Quantified**  
 Performance loss over time  
 Important to define the performance metric used  
 Avoid using only relative degradation rates!  
 Degradation should be expressed as an intrinsic property (ASR)  
 Avoid pitfalls - degradation rate should correspond to observed changes under operation
- Degradation & Lifetime**  
 SOFC degradation rates have reached values of 1% / 1000 h or lower → need to consider measurement time and data quality

# Concluding Remarks

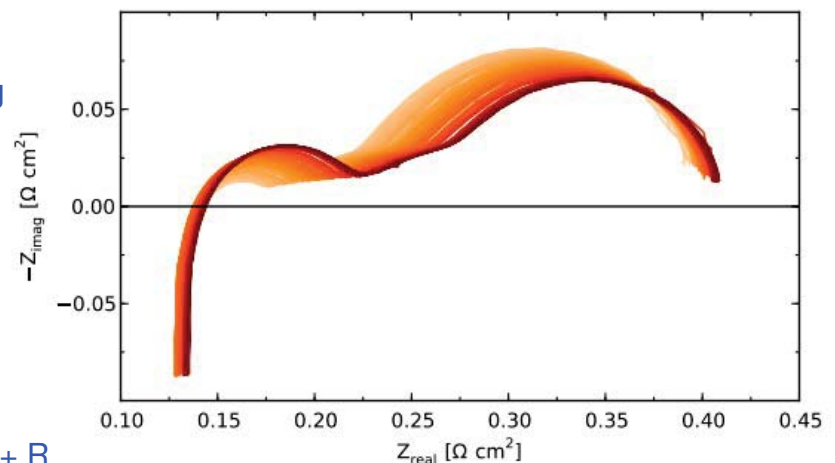


Deconvolution of losses into component and process specific contributions during operation to identify major contributions to degradation, increase understanding, and focus mitigation strategies and development work on critical issues.

ASR is the most useful metric for describing and understanding degradation.

'Normalized' series ( $R_s^0/R_s$ ) and polarisation ( $R_p^0/R_p$ ) also valuable parameters.

$$R_{cell} = R_s + R_p = R_{aux} + R_{electrolyte} + R_{anode} + R_{cathode} + R_{gas,conc}$$



# Acknowledgements

Colleagues at the Fuel Cells and Solid State Chemistry at Risø DTU

Christopher Graves for work on averaging, moving linear fits etc

- Topsoe Fuel Cell A/S 
- Danish Energy Authority 
- Energinet.dk 
- EU Framework Programmes 
- Danish National Advanced Technology Foundation   
Højteknologifonden
- DONG Energy 
- Danish Research Councils

**| Thanks for your attention!**

**| Questions?**

